55 V, N-channel Trench MOSFET

26 November 2014

Product data sheet

1. General description

N-channel enhancement mode Field-Effect Transistor (FET) in a small SOT23 (TO-236AB) Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

2. Features and benefits

- Low threshold voltage
- Very fast switching
- Trench MOSFET technology
- ElectroStatic Discharge (ESD) protection > 3 kV HBM

3. Applications

- Relay driver
- High-speed line driver
- Low-side loadswitch
- Switching circuits

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j = 25 °C		-	-	55	V
V_{GS}	gate-source voltage			-10	-	10	V
I _D	drain current	V _{GS} = 4.5 V; T _{amb} = 25 °C	[1]	-	-	210	mA
		V _{GS} = 4.5 V; T _{sp} = 25 °C		-	-	335	mA
Static characte	Static characteristics						
R _{DSon}	drain-source on-state resistance	V_{GS} = 4.5 V; I_D = 200 mA; T_j = 25 °C		-	2.3	4	Ω

^[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and mounting pad for drain 1 cm².





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5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	<u></u> 3	D I
2	S	source		
3	D	drain	TO-236AB (SOT23)	G S 017aaa255

6. Ordering information

Table 3. Ordering information

Type number	Package					
	Name	Description	Version			
BSH111BK	TO-236AB	plastic surface-mounted package; 3 leads	SOT23			

7. Marking

Table 4. Marking codes

Type number	Marking code [1]
BSH111BK	%4T

[1] % = placeholder for manufacturing site code

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8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{DS}	drain-source voltage	T _j = 25 °C		-	55	V
V_{GS}	gate-source voltage			-10	10	V
I _D	drain current	V _{GS} = 4.5 V; T _{amb} = 25 °C	[1]	-	210	mA
		V _{GS} = 4.5 V; T _{amb} = 100 °C	[1]	-	130	mA
		V_{GS} = 4.5 V; T_{sp} = 25 °C		-	335	mA
I _{DM}	peak drain current	T_{amb} = 25 °C; single pulse; $t_p \le 10 \mu s$		-	0.85	Α
P _{tot}	total power dissipation	T _{amb} = 25 °C	[2]	-	302	mW
			[1]	-	364	mW
		T _{sp} = 25 °C		-	1449	mW
Tj	junction temperature			-55	150	°C
T _{amb}	ambient temperature			-55	150	°C
T _{stg}	storage temperature			-65	150	°C
Source-drain	n diode	,				
Is	source current	T _{amb} = 25 °C	[1]	-	200	mA

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and mounting pad for drain 1 cm².
- [2] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

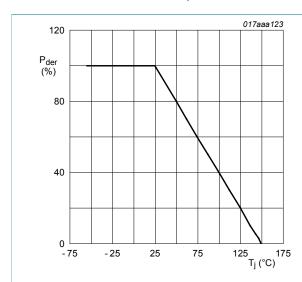


Fig. 1. Normalized total power dissipation as a function of junction temperature

$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100 \%$$

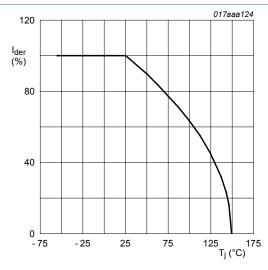


Fig. 2. Normalized continuous drain current as a function of junction temperature

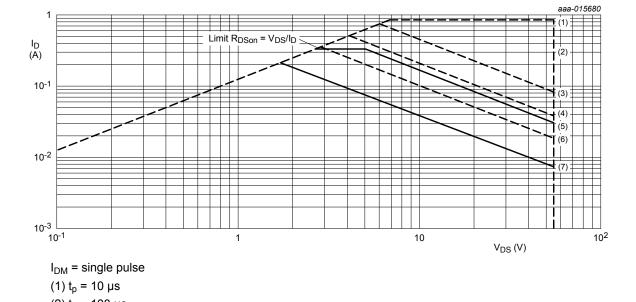
$$I_{der} = \frac{I_D}{I_{D(25^{\circ}\text{C})}} \times 100~\%$$

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(2) $t_p = 100 \ \mu s$

(3) $t_p = 1 \text{ ms}$

(4) $t_p = 10 \text{ ms}$

(5) DC; T_{sp} = 25 °C

(6) $t_p = 100 \text{ ms}$

(7) DC; $T_{amb} = 25 \, ^{\circ}\text{C}$; drain mounting pad 1 cm²

Fig. 3. Safe operating area; junction to ambient; continuous and peak drain currents as a function of drainsource voltage

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
R _{th(j-a)}	thermal resistance from junction to ambient	in free air	[1]	-	351	404	K/W
			[2]	-	271	311	K/W
R _{th(j-sp)}	thermal resistance from junction to solder point			-	65	75	K/W

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and mounting pad for drain 1 cm².

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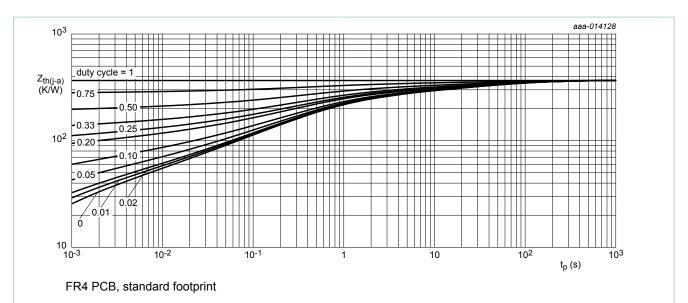


Fig. 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

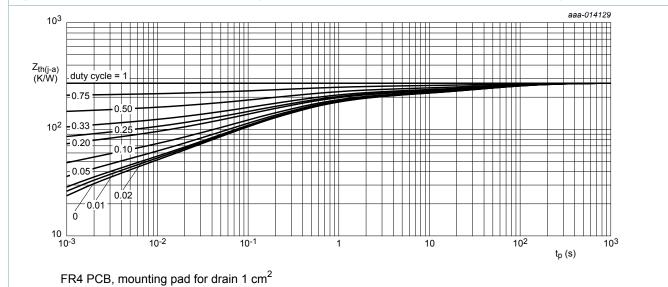


Fig. 5. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

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10. Characteristics

Table 7. Characteristics

Parameter	Conditions	Min	Тур	Max	Unit
racteristics					
drain-source breakdown voltage	I _D = 250 μA; V _{GS} = 0 V; T _j = 25 °C	55	-	-	V
gate-source threshold voltage	$I_D = 250 \mu A; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$	0.6	1	1.3	V
drain leakage current	V _{DS} = 55 V; V _{GS} = 0 V; T _j = 25 °C	-	-	1	μΑ
gate leakage current	V _{GS} = 10 V; V _{DS} = 0 V; T _j = 25 °C	-	-	5	μA
	V _{GS} = -10 V; V _{DS} = 0 V; T _j = 25 °C	-	-	-5	μA
	V_{GS} = 4.5 V; V_{DS} = 0 V; T_j = 25 °C	-	-	0.3	μA
	V _{GS} = -4.5 V; V _{DS} = 0 V; T _j = 25 °C	-	-	-0.3	μΑ
drain-source on-state	V_{GS} = 4.5 V; I_D = 200 mA; T_j = 25 °C	-	2.3	4	Ω
resistance	V _{GS} = 4.5 V; I _D = 200 mA; T _j = 150 °C	-	4.7	8.1	Ω
	V_{GS} = 2.5 V; I_D = 75 mA; T_j = 25 °C	-	2.7	5	Ω
	V_{GS} = 1.8 V; I_D = 30 mA; T_j = 25 °C	-	4.8	-	Ω
forward transconductance	V_{DS} = 10 V; I_{D} = 200 mA; T_{j} = 25 °C	-	0.64	-	S
haracteristics					
total gate charge	V_{DS} = 30 V; I_{D} = 200 mA; V_{GS} = 4.5 V;	-	0.5	-	nC
gate-source charge	T _j = 25 °C	-	0.08	-	nC
gate-drain charge		-	0.16	-	nC
input capacitance	V _{DS} = 30 V; f = 1 MHz; V _{GS} = 0 V;	-	19.1	30	pF
output capacitance	T _j = 25 °C	-	2.7	10	pF
reverse transfer capacitance		-	1.5	7	pF
turn-on delay time	V _{DS} = 30 V; I _D = 200 mA; V _{GS} = 4.5 V;	-	8.3	12	ns
rise time	$R_{G(ext)} = 6 \Omega$; $T_j = 25 °C$	-	8.4	-	ns
turn-off delay time		-	12.6	16	ns
fall time		-	4.8	-	ns
ain diode		l	1	1	
source-drain voltage	I _S = 200 mA; V _{GS} = 0 V; T _i = 25 °C	_	0.86	1.2	V
	drain-source breakdown voltage gate-source threshold voltage drain leakage current gate leakage current drain-source on-state resistance forward transconductance haracteristics total gate charge gate-source charge gate-drain charge input capacitance output capacitance reverse transfer capacitance turn-on delay time rise time turn-off delay time fall time ain diode	$ \begin{array}{c} drain-source \\ breakdown voltage \\ \hline \\ gate-source threshold \\ voltage \\ \hline \\ drain leakage current \\ \hline \\ gate leakage current \\ \hline \\ gate leakage current \\ \hline \\ gate leakage current \\ \hline \\ & V_{DS} = 55 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C} \\ \hline \\ & V_{GS} = 10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C} \\ \hline \\ & V_{GS} = -10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C} \\ \hline \\ & V_{GS} = -4.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C} \\ \hline \\ & V_{GS} = -4.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C} \\ \hline \\ & V_{GS} = 4.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C} \\ \hline \\ & V_{GS} = 4.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C} \\ \hline \\ & V_{GS} = 4.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C} \\ \hline \\ & V_{GS} = 4.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C} \\ \hline \\ & V_{GS} = 4.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C} \\ \hline \\ & V_{GS} = 4.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C} \\ \hline \\ & V_{GS} = 2.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C} \\ \hline \\ & V_{GS} = 1.8 \text{ V}; V_{DS} = 30 \text{ mA}; T_j = 25 \text{ °C} \\ \hline \\ & V_{DS} = 10 \text{ V}; V_{DS} = 30 \text{ mA}; T_j = 25 \text{ °C} \\ \hline \\ & V_{DS} = 10 \text{ V}; V_{DS} = 200 \text{ mA}; V_{GS} = 4.5 \text{ V}; \\ \hline & T_j = 25 \text{ °C} \\ \hline \\ & v_{DS} = 30 \text{ V}; V_{DS} = 200 \text{ mA}; V_{GS} = 4.5 \text{ V}; \\ \hline & T_j = 25 \text{ °C} \\ \hline \\ & v_{DS} = 30 \text{ V}; V_{DS} = 200 \text{ mA}; V_{GS} = 4.5 \text{ V}; \\ \hline \\ & V_{DS} = 30 \text{ V}; V_{DS} = 200 \text{ mA}; V_{GS} = 4.5 \text{ V}; \\ \hline \\ & V_{DS} = 30 \text{ V}; V_{DS} = 200 \text{ mA}; V_{GS} = 4.5 \text{ V}; \\ \hline \\ & v_{DS} = 30 \text{ V}; V_{DS} = 200 \text{ mA}; V_{GS} = 4.5 \text{ V}; \\ \hline \\ & v_{DS} = 30 \text{ V}; V_{DS} = 200 \text{ mA}; V_{CS} = 4.5 \text{ V}; \\ \hline \\ & v_{DS} = 30 \text{ V}; V_{DS} = 200 \text{ mA}; V_{CS} = 4.5 \text{ V}; \\ \hline \\ & v_{DS} = 30 \text{ V}; V_{DS} = 200 \text{ mA}; V_{CS} = 4.5 \text{ V}; \\ \hline \\ & v_{DS} = 30 \text{ V}; V_{DS} = 200 \text{ mA}; V_{CS} = 4.5 \text{ V}; \\ \hline \\ & v_{DS} = 30 \text{ V}; V_{DS} = 200 \text{ mA}; V_{CS} = 4.5 \text{ V}; \\ \hline \\ & v_{DS} = 30 \text{ V}; V_{DS} = 200 \text{ mA}; V_{CS} = 4.5 \text{ V}; \\ \hline \\ & v_{DS} = 30 \text{ V}; V_{DS} = 200 \text{ mA}; V_{CS} = 4.5 \text{ V}; \\ \hline \\ & v_{DS} = 30 \text{ V}; V_{DS} = 200 \text{ mA}; V_{CS} = 4.$			$ \begin{array}{c} drain-source \\ breakdown voltage \\ gate-source threshold \\ voltage \\ drain leakage current \\ gate leakage current \\ \hline \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ $

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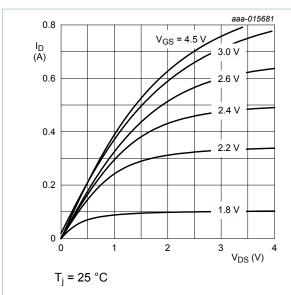
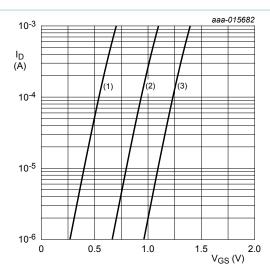


Fig. 6. Output characteristics: drain current as a function of drain-source voltage; typical values



 T_i = 25 °C; V_{DS} = 5 V

- (1) minimum values
- (2) typical values
- (3) maximum values

Fig. 7. Sub-threshold drain current as a function of gate-source voltage

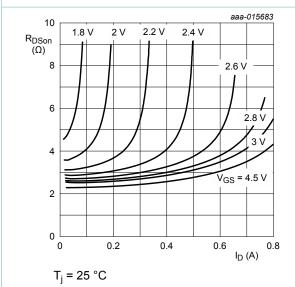
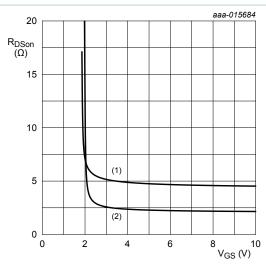


Fig. 8. Drain-source on-state resistance as a function of drain current; typical values



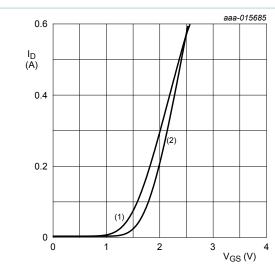
 $I_D = 0.2 A$

(1) $T_i = 150 \, ^{\circ}C$

(2) $T_i = 25 \, ^{\circ}C$

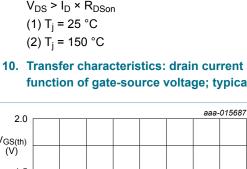
Fig. 9. Drain-source on-state resistance as a function of gate-source voltage; typical values

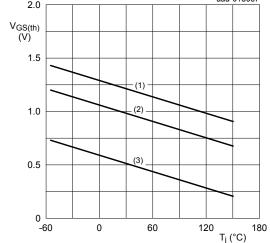
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 $V_{DS} > I_D \times R_{DSon}$

Fig. 10. Transfer characteristics: drain current as a function of gate-source voltage; typical values





 $I_D = 0.25 \text{ mA}; V_{DS} = V_{GS}$

- (1) maximum values
- (2) typical values
- (3) minimum values

Fig. 12. Gate-source threshold voltage as a function of junction temperature

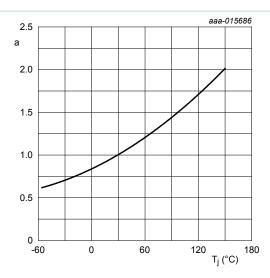
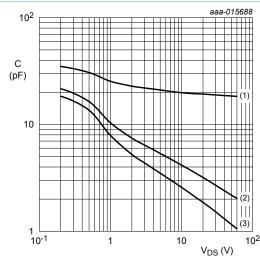


Fig. 11. Normalized drain-source on-state resistance as a function of junction temperature; typical values

$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$



 $f = 1 MHz; V_{GS} = 0 V$

- (1) C_{iss}
- (2) C_{oss}
- (3) C_{rss}

Fig. 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

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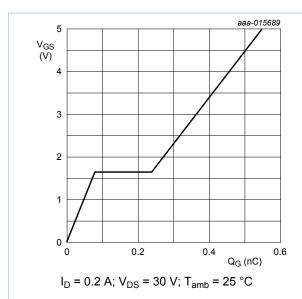


Fig. 14. Gate-source voltage as a function of gate charge; typical values

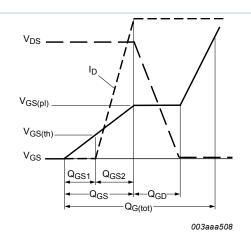
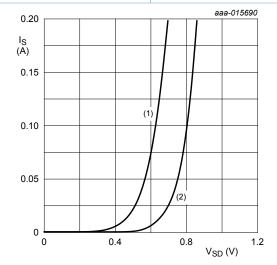


Fig. 15. MOSFET transistor: Gate charge waveform definitions



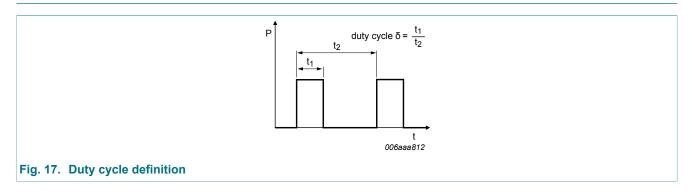
 $V_{GS} = 0 V$ (1) $T_j = 150 \,^{\circ}C$

(2) $T_i = 25 \, ^{\circ}C$

Fig. 16. Source current as a function of source-drain voltage; typical values

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11. Test information

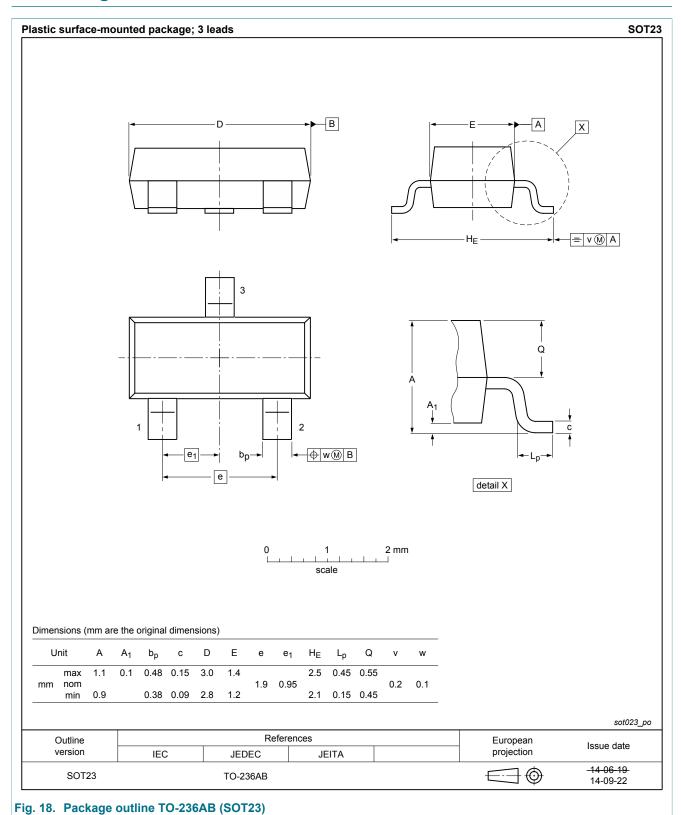


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12. Package outline



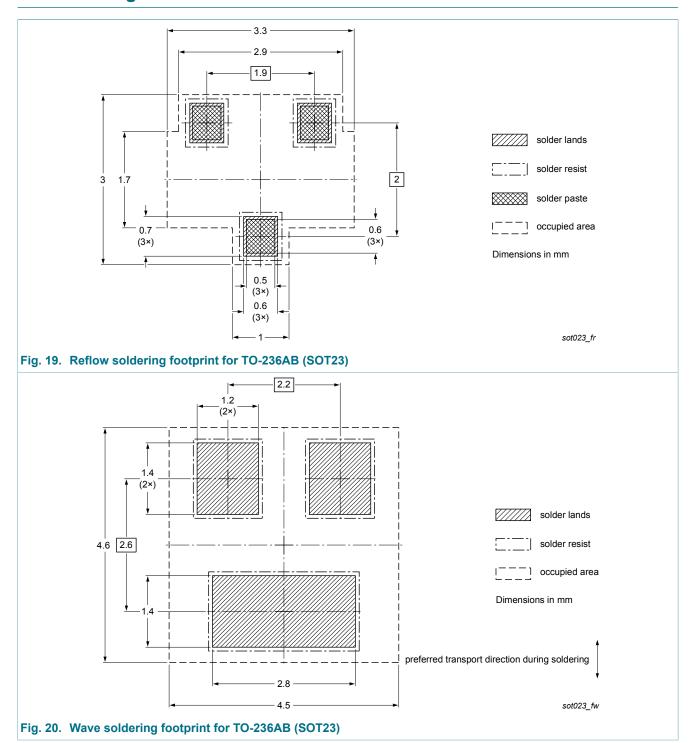
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13. Soldering



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14. Revision history

Table 8. Revision history

Data sheet ID	Release date	Data sheet status	Change notice	Supersedes
BSH111BK v.1	20141126	Product data sheet	-	-

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15. Legal information

15.1 Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
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